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**Additive manufacturing — Test artefacts — Geometric capability assessment of additive manufacturing systems**

*Fabrication additive — Pièces types d'essai — Évaluation de la capacité géométrique des systèmes de fabrication additive*

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ISO copyright office  
CP 401 • Ch. de Blandonnet 8  
CH-1214 Vernier, Geneva  
Phone: +41 22 749 01 11

Email: [copyright@iso.org](mailto:copyright@iso.org)  
Website: [www.iso.org](http://www.iso.org)

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ASTM International  
100 Barr Harbor Drive, PO Box C700  
West Conshohocken, PA 19428-2959, USA  
Phone: +610 832 9634  
Fax: +610 832 9635  
Email: [khooper@astm.org](mailto:khooper@astm.org)  
Website: [www.astm.org](http://www.astm.org)

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## Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular, the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see [www.iso.org/directives](http://www.iso.org/directives)).

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. ISO shall not be held responsible for identifying any or all such patent rights. Details of any patent rights identified during the development of the document will be in the Introduction and/or on the ISO list of patent declarations received (see [www.iso.org/patents](http://www.iso.org/patents)).

Any trade name used in this document is information given for the convenience of users and does not constitute an endorsement.

For an explanation of the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT), see [www.iso.org/iso/foreword.html](http://www.iso.org/iso/foreword.html).

This document was prepared by ISO/TC 261, *Additive manufacturing*, in cooperation with ASTM Committee F42, *Additive Manufacturing Technologies*, on the basis of a partnership agreement between ISO and ASTM International with the aim to create a common set of ISO/ASTM standards on *Additive manufacturing*, and in collaboration with the European Committee for Standardization (CEN) Technical Committee CEN/TC 438, *Additive manufacturing*, in accordance with the Agreement on technical cooperation between ISO and CEN (Vienna Agreement).

This second edition cancels and replaces the first edition (ISO/ASTM 52902:2019), which has been technically revised.

The main changes are as follows:

- addition of a test artefact for testing the performance of the Z-axis in an AM system.
- changed dimensions in text and in drawing (see [Figure 3](#)) of medium circular artefact such that the description in the text matches the dimensions in the downloadable STEP file; [Figure 3](#) was also re-drawn to better depict the circular artefact geometry.

Any feedback or questions on this document should be directed to the user's national standards body. A complete listing of these bodies can be found at [www.iso.org/members.html](http://www.iso.org/members.html).



# Additive manufacturing — Test artefacts — Geometric capability assessment of additive manufacturing systems

## 1 Scope

This document covers the general description of benchmarking test piece geometries, i.e. artefacts, along with quantitative and qualitative measurements to be taken on the benchmarking test piece(s) to assess the performance of additive manufacturing (AM) systems.

This performance assessment can serve the following two purposes:

- AM system capability evaluation;
- AM system calibration.

The benchmarking test piece(s) is (are) primarily used to quantitatively assess the geometric performance of an AM system. This document describes a suite of test geometries, each designed to investigate one or more specific performance metrics and several example configurations of these geometries into test build(s). It prescribes quantities and qualities of the test geometries to be measured but does not dictate specific measurement methods. Various user applications can require various grades of performance. This document discusses examples of feature configurations, as well as measurement uncertainty requirements, to demonstrate low- and high-grade examination and performance. This document does not discuss a specific procedure or machine settings for manufacturing a test piece.

## 2 Normative references

ISO/ASTM 52902:2023

<https://standards.iteh.ai/catalog/standards/sist/9017972c-c2eb-4b1a-8eeb-8b0f6fa7f001/iso->

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO/ASTM 52900, *Additive manufacturing — General principles — Fundamentals and vocabulary*

ASME B46.1, *Surface Texture (Surface Roughness, Waviness and Lay)*

## 3 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO/ASTM 52900 apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at <https://www.iso.org/obp>
- IEC Electropedia: available at <https://www.electropedia.org/>

## 4 Significance and use

### 4.1 General

Measurements and observations described in this document are used to assess the performance of an AM system with a given system set-up and process parameters, in combination with a specific feedstock material.

The primary characterization of the AM system obtained by applying this document is via geometric accuracy, surface finish, and minimum feature sizes of the benchmarking test piece(s).

### 4.2 Comparing results from one machine

The test piece(s) can be built and measured for example when the new machine is installed. The test piece(s) can be used to periodically evaluate the performance or diagnose a fault in one AM system, for example, after system maintenance or as specified by the requirements of a quality system.

The test piece(s) described in this test method can be used as a demonstration of capabilities for a contract between a buyer and seller of AM parts or AM systems.

Data from the measurements described in this document can be used to gauge the impact of new process parameters or material on the AM system performance.

Certain test geometries can be included with every build on a particular AM system to help establish performance traceability. Depending on the needs of the user, not all test artefacts need to be built, and individual test artefacts can be built separately if required.

## 5 General principles for producing test artefacts

### 5.1 General

This clause outlines principles applicable for producing all of the test artefact geometries in this document. Reporting requirements are previewed in connection with the production steps in this clause, but more details about recording and reporting can be found with the individual artefact descriptions given in [Clause 7](#).

### 5.2 Need to use feedstock conforming to a material specification

In order to ensure repeatable results, the use of a quality feedstock material is needed. Clear definition of the material specification is important. Often a standard specification is preferred, but specifications do not need to be limited to standards and can be defined by the user. A feedstock material specification should be selected or required by the user and the feedstock used for test artefact trials should match said specification. For example, the specification can include the particulate properties (particle size, size distribution, morphology) for powder feedstock, bulk properties (such as flow) and chemical properties (such as chemical composition and level of contamination). Although the details of the material specification shall not be disclosed (unless otherwise agreed between buyer and seller), it should be documented by the producer and reported with a unique alphanumeric designation as specified by ASTM F2971-13:2021, Annex A1, element “B”. For powder-based processes, the material specification should specifically address limitations of powder re-use and percent of virgin/re-used powder.

### 5.3 Need to undertake artefact building according to a documented process specification

The processing of the material in the AM system should be undertaken according to a documented process specification/manufacturing plan, as specified by ASTM F2971-13:2021, Annex A1, element “C”. This can be a proprietary internal standard or external standard (subject to buyer/seller negotiations), but the producer should document the exact values of user-specifiable settings and conditions surrounding the building of parts. For example, it should document the layer thickness, build strategies (e.g. scan path, tool path, and/or scan parameters), temperatures, etc. used during the build. This process should be consistent for all test artefacts produced within one build. These recommendations can be different for each use, so the parameters in the process specification should be agreed between the buyer and seller.



## 5.4 File formats and preparation

The file formats used and steps of the digital file preparation including slice parameters should be included in the process specification. Care shall be taken during the creation and transfer of data files to avoid degradation of the model. Any discrepancy between these affects the outcome of tests on the artefacts and for this reason, good practice for the control of the file formats and preparation is discussed here.

## 5.5 Download files

The 3D digital models for standard test artefact geometries can be downloaded in \*.step format at <https://standards.iso.org/iso/52902/ed-2/en>. For a complete list of available files, please see [Annex D](#).

## 5.6 Discussion of file conversion

When a CAD model is converted to AMF, STL, or any intermediate file format, sufficient fidelity shall be maintained to ensure that the test artefact produced from it fairly reflects the capabilities of the AM system under assessment. The file conversion tolerance selected should ensure that the maximum deviation of the data from the nominal CAD model is less than one quarter and ideally less than one tenth of the expected accuracy of the AM system being assessed. Currently, most additive manufacturing equipment cannot produce features with a resolution better than 10 µm, therefore CAD models are saved to STL/AMF ensuring at least a 2,5 µm accuracy or better. This is only general guidance and should be confirmed for the specific output system. It is recommended that users check the maximum deviation and record the conversion parameters used, as well as any maximum deviation (chord height and angular tolerance).

Files should not be scaled up or down either during conversion or afterward. Machine correction factors (e.g. offsets, axis scaling, etc.) may be used and should be documented as part of the process specification.

## 5.7 AMF preferred (with conversion instructions/ resolutions)

The AMF file format as specified by ISO/ASTM 52915 is the preferred model format for test artefact geometry representation due to its ability to store high fidelity geometry with embedded units in an intermediate file format, and for its ability to accurately orient an array of parts within a single AMF file.

## 5.8 Need for test specification and test process

This document forms the basis for the general *Test Plan/Specification* described in ASTM F2971-13:2021, Annex A1, element “D”, but specifics about its implementation need recording to accurately document the test process (element “E” in Annex A1), used for producing the parts as discussed in [Clause 7](#).

## 5.9 Quantity of test artefacts

For a complete test of machine performance, at least two things dictate the quantity of the test artefacts produced. First, the test specification/test process shall ensure a quantity of samples, typically no less than five per build, so that statistically significant measurements can be made. Second, sufficient coverage (see [5.13](#)) of the build platform needs to be made to account for variations in performance between build locations. Repeated builds can also be completed to test the repeatability of the process. Fewer test artefacts with less complete coverage may be used for spot checks or limited demonstrations, such as the example detailed in [Annex A](#). The number of artefacts shall be agreed upon between the buyer and seller and shall permit to perform at least 5 measurements.

### 5.10 Position and orientation of test artefacts

As per ASTM F2971-13:2021, Annex A1, element “F”, it is recommended to report results in combination with the test artefacts’ build position and orientations according to the convention set forth in ISO 17295.

### 5.11 Considerations for orientation

Since these test artefacts are intended to reveal the strengths and weaknesses of additive building techniques, there will be failed build geometries. It is worth considering which features are likely to fail and place them in positions or orient them at angles that minimize the risk that this leads to an outright failure of the features/parts/artefacts in the rest of the build. For example, in a powder bed process, it can be advisable to position parts that are more likely to fail at a higher level in the overall build to reduce the risk that failed parts or sections of parts impinge on other components in the build or the AM machine mechanism.

### 5.12 Labelling

It can be useful to add labels to parts to identify respective artefact orientations and positions in the build. Labelling is summarized in [7.5](#).

### 5.13 Coverage

It is important that test artefacts be made with sufficient coverage of the build volume to get representative data for where real parts are made. Coverage evaluates variability throughout the build volume. This is good practice for all AM processes and is especially critical for processes that have a “sweet spot” (for example, some galvanometric laser beam steering systems give more repeatable results in the centre of the platform). The artefact distribution should span at least 80 % of the machine’s build platform area, with the intent that the artefacts are built at different locations based on the applications of the user and where components will be built on the machine in production. For machines with large build platform areas, artefacts could be placed at the outer ends of the build platform area and at the centre of the build platform area to provide some coverage of the entire build area. If build location effects are known or deemed irrelevant for the trial being performed, then a single build location may be selected and used, as agreed between buyer and seller.

Long artefacts, which reach across the extents of the build volume, can be necessary to detect corrections that are not linear or are periodic in nature.

### 5.14 Arrays

Geometry should not be scaled to accommodate different sizes of build volumes (since this affects the measurement outputs) but can be patterned in an array to give larger coverage areas. See an example in [Figure 2](#). Scaling of artefact geometry to accommodate shrinkage, such as in applications using binder jetting AM, should be clearly documented by users.

### 5.15 Part consolidation

When arrays of parts are needed for better coverage, it can be most practical to build a single combined part instead of trying to build arrays of adjacent individual parts. This can be achieved by consolidating adjacent AMF or STL files prior to slicing and other file preparation steps. Arrays of parts can be accurately positioned relative to each other in a single AMF file by use the “constellation” element.

As AM most commonly is a layered process (in Z-direction) and often based on pixels (in X/Y-direction), the exact position of the part in the build can affect the test significantly. This is especially true of artefacts testing machine resolution. A minor translation of the part can influence rounding off issues influencing whether a specific layer or pixel will build or not. This can be caused during preparation of the slice file and during orienting the slice file into the working area in the machine. Results should be

reported in combination with the test artefacts' build orientations according to the convention set forth in ISO 17295.

With certain AM processes (especially with metals), heat build-up from processing large cross-sectional areas near the test artefacts can affect their geometrical accuracy. Therefore, it is advised that the manufacturer ensure compliance with specified distances between parts.

### 5.16 Supports and post processing

Where possible, supports should be avoided or supports which do not impede or affect in any way the intended measurement should be employed. Supporting strategy, including, but not limited to material, geometry, removal technique, etc., shall be fully documented in the process specification.

Data reported from this document shall be in the as-built condition prior to any surface or downstream processing. In the case of unavoidable post-processing undertaken prior to measurement (e.g. removal of necessary support material), details of the process shall be reported as part of the process specification. The reporting should include a description of any used abrasive media and how it was applied to the surface of the artefacts. In addition, data after additional post-processing treatments (such as sand blasting of metal parts for example) may be obtained but only if clearly noted and presented together with as-built measurements. In the case of sinter-based processes, users shall report the condition of the part used for testing, such as stating "measurements were taken on the sintered body with scaling applied to account for shrinkage," "measurements were taken on the green body with (or without) scaling applied."

## 6 General principles for measuring artefacts

### 6.1 General

This clause outlines principles applicable for measuring all the test artefact geometries in this document. The specific measurements are specified in [Clause 7](#) describing the individual artefact geometries. This document does not prescribe any specific measurement methods; the measurements described below can be accomplished by a variety of techniques and devices (e.g. coordinate measuring machine, optical scanner, dial indicators with calibrated motion devices, surface profilometers, etc.). ISO/ASTM 52927 can be used to improve communication between stakeholders concerning test methods. Reporting requirements are previewed in connection with the measurement steps in this clause but more details about recording and reporting can be found in [Annexes B](#) and [C](#).

### 6.2 Measure parts as built

The test artefact should be allowed to cool to room temperature and then measured directly after it is removed from the system used to build it, before any post-processing is performed. The user can require that parts be held at a set temperature and humidity prior to measurement. If the parts are built by a powder bed-based process, the parts should be completely separated from the surrounding powder before measurement. If the parts are built on a build platform, first perform the measurements without removing the part from the platform. (Removal from a build platform can affect the shapes of the artefacts, thereby influencing the results. If measurement is not possible on the platform, this shall be explicitly stated in the report.) If post-processing is desired, report all details of each post-processing step and measure the part before and after each post-processing steps (reporting all measurement results).

### 6.3 Measurement strategy

Measurement strategy affects the overall measurement uncertainty; this is true for dimensional measurements and surface measurements alike. Measurement strategy, here, involves the device chosen to perform the measurement along with the number of points selected to represent the feature or surface and the distribution of points along the feature or surface. For roughness measurements, the measurement strategy includes any applied filters (e.g. the cut-off length). Measurement strategy

is a complicated subject and is often very specific to the part or feature being measured. As such, there is no general “good practice” for performing these measurements. However, some tips are provided in [Annexes B](#) and [C](#). The measurement uncertainty is ultimately the important concept, and, with consideration given to the available measurement devices, using a measurement strategy that minimizes the measurement uncertainty within any given constraints should be the primary focus.

## 6.4 Measurement uncertainty

The standard uncertainty of each measurement should be reported along with the measurement. Guidance on determining measurement uncertainty can be found in the following references:

- ASME B89.7.3.2 for uncertainty in dimensional measurements;
- ASME B46.1 for surface texture measurements;
- JCGM 100 and JCGM 101 for measurement uncertainty in general (commonly referred to as the Guide to the expression of uncertainty in measurement, or GUM);
- ISO/IEC Guide 98-1 and related documents.

Users should document any calibration and/or quality maintenance system for the measurement processes and equipment used. Measurement device and resolution shall be disclosed in the report.

Measurement system analysis (MSA) and Gage Repeatability and Reproducibility (R&R) are also acceptable approaches to perform measurement uncertainty evaluation. See ASTM E2782.

## 7 Artefact geometries

### 7.1 General

Eight types of artefacts are described in the following subclauses. Each artefact is intended to test a different aspect of a system’s performance or capability.

### 7.2 Accuracy

#### 7.2.1 Linear artefact

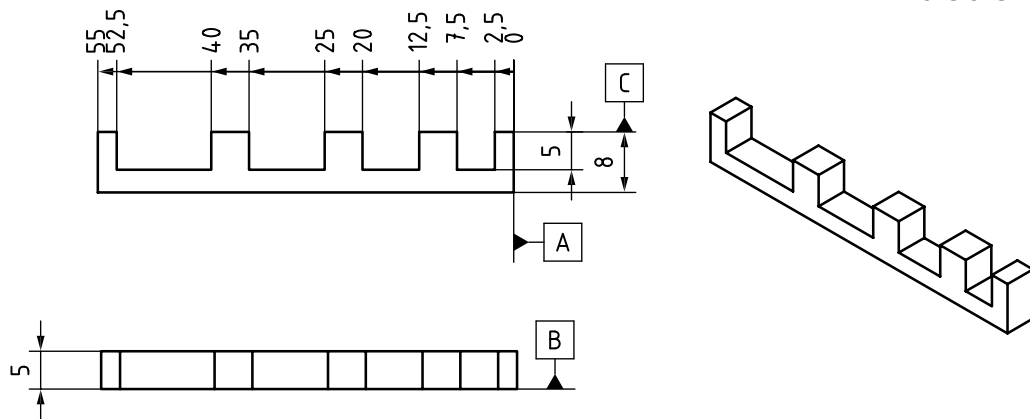
##### 7.2.1.1 Purpose

This artefact tests the linear positioning accuracy along a specific machine direction. Depending on artefact orientation and machine configuration, errors in the artefact can provide a basis for positioning compensation or diagnosing specific error motions in the system’s positioning system.

##### 7.2.1.2 Geometry

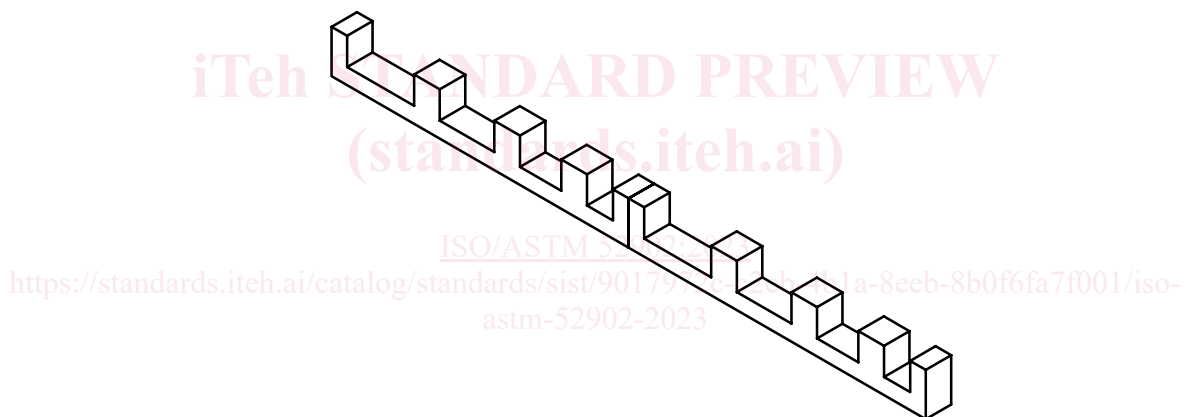
[Figure 1](#) depicts the geometry of the linear artefact. The artefact comprises prismatic protrusions atop a rectangular solid base. A bounding box for the entire feature is 55 mm × 5 mm × 8 mm. The end protrusions are 2,5 mm × 5 mm × 5 mm. The central protrusions are 5 mm cubes. Spacing of the protrusions increases along the length of the artefact from 5 mm to 7,5 mm, 10 mm, and 12,5 mm.

Dimensions in millimetres



**Figure 1 — Engineering drawing of linear test artefacts**

If a longer test of linear accuracy is desired, multiple linear artefacts can be appended to one another. The 2,5 mm length of the end protrusions means that when two or more linear artefacts are appended, the central protrusions will all be 5 mm cubes. [Figure 2](#) shows an example. If this option is chosen, see [5.15](#).



**Figure 2 — Two linear accuracy test artefacts appended to each other**

If a shorter test of linear accuracy is required, the geometry of an alternative test artefact shall be agreed upon by the buyer and seller and shall follow similar design principles to the part shown in [Figure 1](#). The alternative artefact should have non-equally spaced features and should test both protrusions and gaps (i.e. distances with material in between features and distances with space in between features).

### 7.2.1.3 Measurement

The primary measurement for the linear artefact is the position of the cube faces relative to the primary datum at the end of the artefact (see [Figure 1](#)). Alternatively, the lengths of each protrusion can be measured and the spacing between each protrusion can be measured. Optional measurements available are the straightness of the base along the length of the artefact, parallelism of each side of the base along the length of the artefact and the heights of each protrusion.

### 7.2.1.4 Considerations

Default orientations for a thorough overview of linear accuracy should include at least one test artefact aligned parallel to each axis (X, Y, and Z) in the machine coordinate system. When this is done, orthogonal orientation notation should be used to document the orientation as per ISO 17295. An alternative can be to align one linear artefact with the motion of one of the machine's positioning axes